


<b>Search Notes</b> 	<b>Application/Control No.</b> 10720847	<b>Applicant(s)/Patent Under Reexamination</b> KIMURA, HAJIME
	<b>Examiner</b> Michael Pervan	<b>Art Unit</b> 2629

### SEARCHED

Class	Subclass	Date	Examiner
345	76-81, 204	3/5/2007	MP
above	updated	10/25/2007	MP
above	updated	5/10/2008	MP
above	updated	12/6/2008	MP
above	updated	5/21/2009	MP
above	updated	12/5/2009	MP
above	updated	11/18/2010	MP
345	55-59, 82-104, 205-215, 690-699	11/18/2010	MP

### SEARCH NOTES

Search Notes	Date	Examiner
see attached EAST search results	3/5/2007	MP
see attached updated EAST search results	10/25/2007	MP
see attached updated EAST search results	5/10/2008	MP
see attached updated EAST search results	12/6/2008	MP
see attached updated EAST search results	5/21/2009	MP
see attached updated EAST search results	12/5/2009	MP
see attached updated EAST search results	11/18/2010	MP
Interference search: (gate near3 (width length) with (smaller larger) same (first and second) near3 transistor same pre\$1charge).clm.	11/18/2010	MP

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
345	55-59, 76-104, 204-215, 690-699	11/18/2010	MP

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